

AS7C34098A-8TIN 256K X 16 BIT HIGH SPEED CMOS SRAM

REVISION HISTORY

Revision	<u>Description</u>	Issue Date
Rev. 1.0	Initial Issue	Jul.12.2012
Rev. 1.1	"CE# \geq V _{CC} - 0.2V" revised as "CE# \leq 0.2V" for TEST CONDITION	Jul.19.2012
	of Average Operating Power supply Current	
	lcc1 on page3	
Rev. 1.2	Revised $V_{IH(max)}/V_{IL(min)}$ in	May.7.2013
	DC ELECTRICAL CHARACTERISTICS	
	Added in t _{BA} /t _{BHZ*} /t _{BLZ*}	
	in AC ELECTRICAL CHARACTERISTICS	
	Added WRITE CYCLE 3 in TIMING WAVEFORMS	
Rev. 1.3	1. Revise " TEST CONDITION " for V _{OH} , V _{OL} on page 5	Jun.04.2013
	I _{OH} = -8mA revised as -4mA	
	I _{OL} =4mA revised as 8mA	
	2. Revise V _{IH(max)} & V _{IL(min)} note on page 5	
	$V_{IH(max)} = V_{CC} + 2.0V$ for pulse width less than 6ns.	
	$V_{IL(min)} = V_{SS} - 2.0V$ for pulse width less than 6ns.	
Rev. 1.4	Revised the address pin sequence of TSOP-II pin configuration on	Sep.23.2013
	page 3 in order to be compatible with industry convention. (No	
	function specifications and applications have been changed and all	
	the characteristics are kept all the same as Rev 1.3)	
	Added t _{BW} in AC ELECTRICAL CHARACTERISTICS	
	Revised WRITE CYCLE 1,2 in TIMING WAVEFORMS	



AS7C34098A-8TIN

FEATURES

■ Fast access time: 8ns

■ Low power consumption:

Operating current: 50mA(TYP.) Standby current: 2mA(TYP.)

■ Single 3.3V power supply

■ All inputs and outputs TTL compatible

■ Fully static operation

■ Industrial temperature -40°~85°C

■ Tri-state output

■ Data byte control : LB# (DQ0 ~ DQ7)

UB# (DQ8 ~ DQ15)

Data retention voltage : 1.5V (MIN.)
Greenpackage/ROHS compliant (N)
Package : 44-pin 400 mil TSOP-II

GENERAL DESCRIPTION

The AS7C34098A is a 4,194,304-bit high speed CMOS static random access memory organized as 262144 words by 16 bits. It is fabricated using very high performance, high reliability CMOS technology. Its standby current is stable within the range of operating temperature.

The AS7C34098A operates from a single power supply of 3.3V and all inputs and outputs are fully TTL compatible

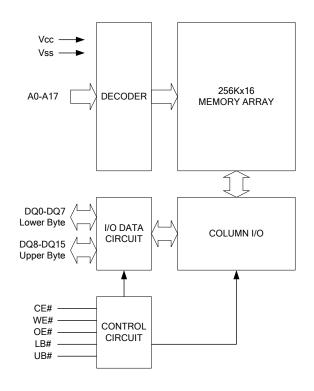
PRODUCT FAMILY

Product	Operating	Vcc Range Speed Power Dissipation Standby(IsB1,TYP.) Operation		Dissipation	
Family	Temperature			Standby(ISB1,TYP.)	Operating(Icc1,TYP.)
AS7C34098A(I)	-40°~85°C	3.0 ~ 3.6V	8ns	2mA	50mA



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FUNCTIONAL BLOCK DIAGRAM



PIN DESCRIPTION

SYMBOL	DESCRIPTION
A0 - A17	Address Inputs
DQ0 – D15	Data Inputs/Outputs
CE#	Chip Enable Inputs
WE#	Write Enable Input
OE#	Output Enable Input
LB#	Lower Byte Control
UB#	Upper Byte Control
Vcc	Power Supply
Vss	Ground
NC	No Connection



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PIN CONFIGURATION

				1
A0	1		44	A17
A1	2		43	A16
A2	3		42	A15
A3	4		41	OE#
A4	5		40	UB#
CE#	6		39	LB#
DQ0	7	_	38	DQ15
DQ1	8	\triangleright	37	DQ14
DQ2	9	S	36	DQ13
DQ3	10	2 2 3	35	DQ12
Vcc	11	ζ ζ 	34	Vss
Vss	12	34098, (XXX (XXX	33	Vcc
DQ4	13	$\mathcal{S} \mathcal{S} \mathcal{S}$	32	DQ11
DQ5	14	$\widetilde{\Omega}$	31	DQ10
DQ6	15	\triangleright	30	DQ9
DQ7	16		29	DQ8
WE#	17		28	NC
A5	18		27	A14
A6	19		26	A13
A7	20		25	A12
A8	21		24	A11
A9	22		23	A10
				J

TSOP II(Top View)



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ABSOLUTE MAXIMUM RATINGS*

PARAMETER	SYMBOL	RATING	UNIT
Voltage on Vcc relative to Vss	V _{T1}	-0.5 to 4.6	V
Voltage on any other pin relative to Vss	V _{T2}	-0.5 to Vcc+0.5	V
Operating Temperature	Та	-40 to 85(I grade)	$^{\circ}$
Storage Temperature	Тѕтс	-65 to 150	°C
Power Dissipation	PD	1	W
DC Output Current	Іоит	50	mA

^{*}Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect device reliability.

TRUTH TABLE

MODE	CF#	CE# OE#		WE# LB#		I/O OPERATION		SUPPLY CURRENT	
MODE	OL#	OL#	***	LD#	UB#	DQ0-DQ7	DQ8-DQ15	OOI I EI OOKKENI	
Standby	Н	Х	Х	Х	Х	High – Z	High – Z	I _{SB} ,I _{SB1}	
Output Disable	L	Н	Н	Х	Х	High – Z	High – Z	loo loos	
Output Disable	L	Х	Х	Н	Н	High – Z	High – Z	lcc,lcc1	
	L	L	Н	L	Н	D _{out}	High – Z		
Read	L	L	Н	Н	L	High – Z	D _{OUT}	Icc,Icc1	
	L	L	Н	L	L	D_OUT	D _{OUT}		
	L	Х	L	L	Н	D _{IN}	High – Z		
Write	L	Х	L	Н	L	High – Z	D _{IN}	Icc,Icc1	
	L	X	L	L	L	D_IN	D _{IN}		

Note: H = V_{IH}, L = V_{IL}, X = Don't care



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DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		MIN.	TYP. ^{*4}	MAX.	UNIT
Supply Voltage	Vcc	-	·8	3.0	3.3	3.6	V
Input High Voltage	V _{IH} ^{*1}			2.2	-	Vcc+0.3	V
Input Low Voltage	V _{IL} ²			- 0.3	-	8.0	V
Input Leakage Current	ILI	$V_{CC} \ge V_{IN} \ge V_{SS}$		- 1	-	1	μA
Output Leakage Current	ILO	Vcc ≧ Vouт ≧ Vss, Output Disabled		- 1	-	1	μA
Output High Voltage	Vон	I _{OH} = -4mA		2.4	-	-	V
Output Low Voltage	Vol	I _{OL} = 8mA		-	-	0.4	V
Average Operating	Icc	Cycle time = Min. CE# = V _{IL} , I _{I/O} = 0mA, Others at V _{IL} or V _{IH}	-8	-	65	80	mA
Power supply Current	lcc1	CE# \leq 0.2, Others at 0.2V or Vcc-0.2V $I_{I/O}$ = 0mA;f=max	-8	-	50	60	mA
Standby Dower	IsB	CE# =V _{IH} , Others at V _I L or V	/н	-	-	30	mA
Standby Power Supply Current	I _{SB1}	CE# \geq V _{CC} - 0.2V, Others at 0.2V or V _{CC} - 0.2V	/	-	2	10	mA

Notes:

- 1. $V_{IH}(max) = V_{CC} + 2.0V$ for pulse width less than 6ns.
- 2. VIL(min) = Vss 2.0V for pulse width less than 6ns.
- 3. Over/Undershoot specifications are characterized on engineering evaluation stage, not for mass production test.
- 4. Typical values are included for reference only and are not guaranteed or tested. Typical valued are measured at V_{CC} = V_{CC} (TYP.) and T_A = 25°C

CAPACITANCE (TA = 25%, f = 1.0MHz)

PARAMETER	SYMBOL	MIN.	MAX	UNIT
Input Capacitance	Cin	-	8	pF
Input/Output Capacitance	C _{I/O}	-	10	pF

Note: These parameters are guaranteed by device characterization, but not production tested.

AC TEST CONDITIONS

Speed	8ns
Input Pulse Levels	0.2V to Vcc - 0.2V
Input Rise and Fall Times	3ns
Input and Output Timing Reference Levels	1.5V
Output Load	$C_L = 30pF + 1TTL$, $I_{OH}/I_{OL} = -4mA/8mA$



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Rev. 1.4

AC ELECTRICAL CHARACTERISTICS

(1) READ CYCLE

PARAMETER	SYM.	AS7C34	UNIT	
FARAWLILK	STIVI.	MIN.	MAX.	UNIT
	trc	8	-	ns
Address Access Time	taa	-	8	ns
Chip Enable Access Time	t ace	-	8	ns
	toe	-	4.5	ns
	tclz*	2	-	ns
· ·	tolz*	0	-	ns
	tcнz*	-	3	ns
Output Disable to Output in High-Z	toнz*	-	3	ns
Output Hold from Address Change	tон	2	-	ns
LB#, UB# Access Time	t BA	-	4.5	ns
LB#, UB# to High-Z Output	t _{BHZ} *	-	3	ns
LB#, UB# to Low-Z Output	t _{BLZ} *	0	-	ns

(2) WRITE CYCLE

PARAMETER	SYM.	AS7C34	UNIT	
PARAMETER	STIVI.	MIN.	MAX.	UNIT
Write Cycle Time	twc	8	-	ns
Address Valid to End of Write	taw	6.5	-	ns
Chip Enable to End of Write	tcw	6.5	-	ns
Address Set-up Time	t as	0	-	ns
Write Pulse Width	twp	6.5	-	ns
Write Recovery Time	twr	0	-	ns
Data to Write Time Overlap	tow	5	-	ns
Data Hold from End of Write Time	tон	0	-	ns
Output Active from End of Write	tow*	2	-	ns
Write to Output in High-Z	twnz*	-	3	ns
LB#, UB# Valid to End of Write	t _{BW}	6.5	ı	ns

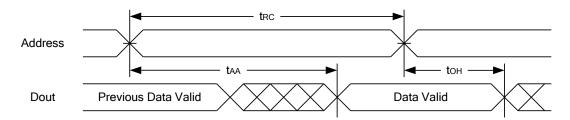
^{*}These parameters are guaranteed by device characterization, but not production tested.



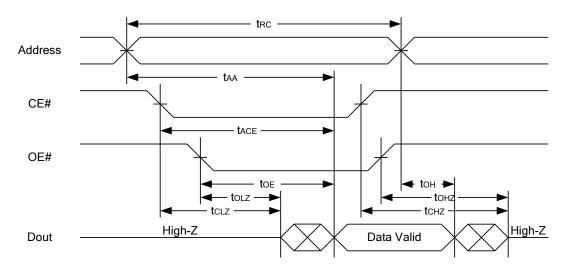
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TIMING WAVEFORMS

READ CYCLE 1 (Address Controlled) (1,2)



READ CYCLE 2 (CE# and OE# Controlled) (1,3,4,5)



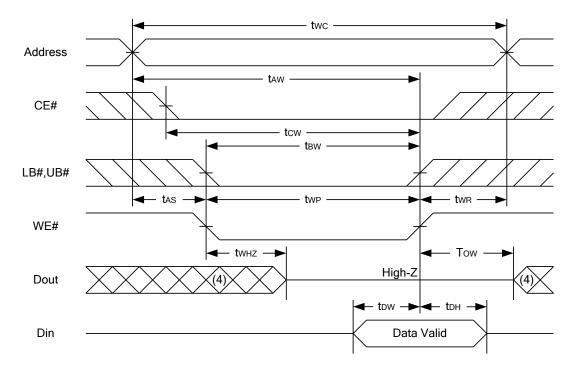
Notes:

- 1.WE# is high for read cycle.
- 2.Device is continuously selected OE# = low, CE# = low.
- 3.Address must be valid prior to or coincident with CE# = low,; otherwise tAA is the limiting parameter.
- 4.tclz, tolz, tchz and tohz are specified with CL = 5pF. Transition is measured ±500mV from steady state.
- 5.At any given temperature and voltage condition, tcHz is less than tcLz, toHz is less than toLz.

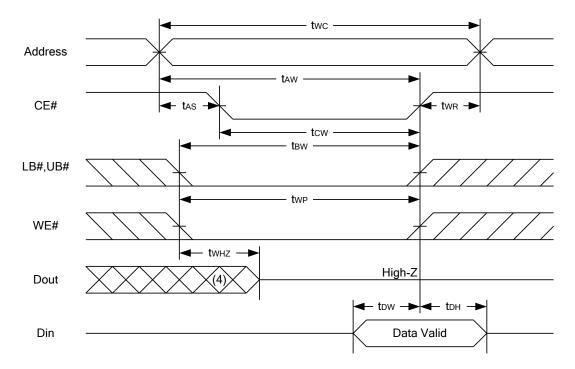


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WRITE CYCLE 1 (WE# Controlled) (1,2,3,5,6)



WRITE CYCLE 2 (CE# Controlled) (1,2,5,6)

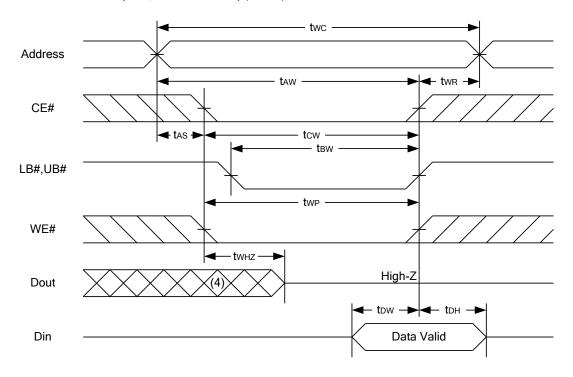


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WRITE CYCLE 3 (LB#,UB# Controlled) (1,2,5,6)



Notes:

- 1.WE#,CE#, LB#, UB# must be high during all address transitions.
- 2.A write occurs during the overlap of a low CE#, low WE#, LB# or UB# = low.
- 3.During a WE# controlled write cycle with OE# low, twp must be greater than twnz + tow to allow the drivers to turn off and data to be placed on the bus.
- 4. During this period, I/O pins are in the output state, and input signals must not be applied.
- 5.If the CE#, LB#, UB# low transition occurs simultaneously with or after WE# low transition, the outputs remain in a high impedance
- 6.tow and twHz are specified with CL = 5pF. Transition is measured ±500mV from steady state.



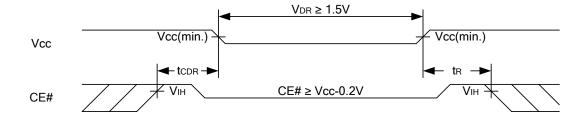
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DATA RETENTION CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Vcc for Data Retention	V _{DR}	CE# ≧ Vcc - 0.2V	1.5	-	3.6	V
Data Retention Current	ldr	V _{CC} = 1.5V CE# ≧ V _{CC} - 0.2V Others at 0.2V or V _{CC} - 0.2V	-	2	10	mA
Chip Disable to Data Retention Time	tcdr	See Data Retention Waveforms (below)	0	-	-	ns
Recovery Time	t _R		t RC∗	-	-	ns

tRC∗ = Read Cycle Time

DATA RETENTION WAVEFORM

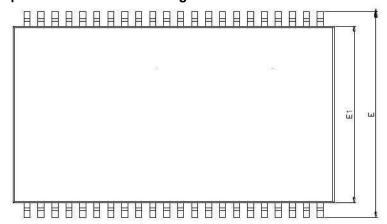


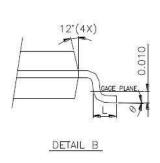


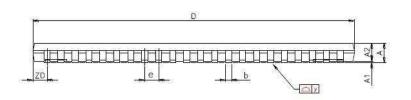
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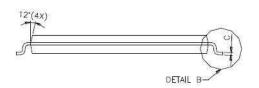
PACKAGE OUTLINE DIMENSION

44-pin 400mil TSOP-II Package Outline Dimension









SYMBOLS	DIMENSIONS IN MILLMETERS			DIMENSIONS IN MILS		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
Α	-	-	1.20	-	-	47.2
A1	0.05	0.10	0.15	2.0	3.9	5.9
A2	0.95	1.00	1.05	37.4	39.4	41.3
b	0.30	-	0.45	11.8	-	17.7
С	0.12	-	0.21	4.7	-	8.3
D	18.212	18.415	18.618	717	725	733
E	11.506	11.760	12.014	453	463	473
E1	9.957	10.160	10.363	392	400	408
е	-	0.800	-	-	31.5	-
L	0.40	0.50	0.60	15.7	19.7	23.6
ZD	ı	0.805	-	-	31.7	-
У	-	-	0.076	-	-	3
θ	0°	3°	6°	0°	3°	6°



AS7C34098A-8TIN

ORDERING INFORMATION

Package Type	Access Time (Speed/ns)	Temperature Range(℃)	Packing Type	Alliance Memory Part No.
44Pin(400mil)	8	-40℃~85℃		AS7C34098A-8TIN
TSOP-II			Tape Reel	AS7C34098A-8TINTR



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